#### **General Description**

The SJ046N10 uses SGT technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and fast switching characteristics. This device is suitable for use as a wide variety of applications.

#### **Features**

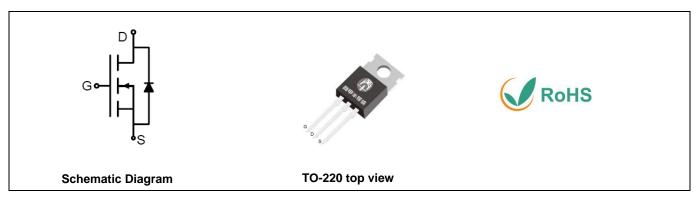
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

#### **Application**

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

### **Key Performance Parametes**

Parameter	Value	Unit
V <sub>DS</sub>	100	V
R <sub>DS(ON)_TYP</sub>	4.3	mΩ
I <sub>D</sub>	143	A
Q <sub>G</sub>	47	nC



### **Package Marking and Ordering Information**

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJ046N10	SJ046N10	TO-220	Tube	\	\	1000 Pcs

### Table 1. Absolute Maximum Ratings (T<sub>C</sub>=25℃ unless otherwise noted)

Symbol	Parameter Limit		Unit
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	100	V
Vgs	Gate-Source Voltage (V <sub>DS</sub> =0V)	(V <sub>DS</sub> =0V) ±20	
	Drain Current-Continuous(Tc=25℃)	143	А
l <sub>D</sub>	Drain Current-Continuous(Tc=100℃)	91	А
I <sub>DM</sub> (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	572	А
D-	Maximum Power Dissipation(Tc=25°C)	208	
P <sub>D</sub>	Maximum Power Dissipation(Tc=100°C)	83	W
Eas	Avalanche energy (Note 2)	625	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	°C

#### Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case		0.6	°C/W



Table 3. Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

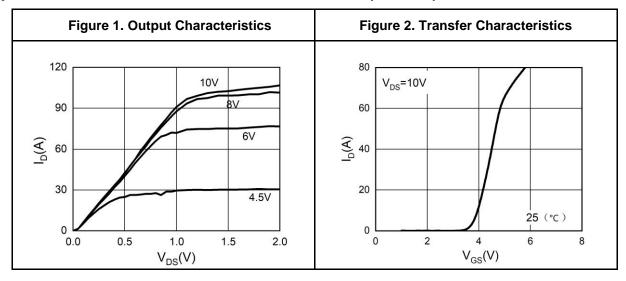
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	Voltage V <sub>GS</sub> =0V I <sub>D</sub> =250μA				V
	7 0 1 1/1 5 1 0 1	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V T <sub>J</sub> =25°C			1	μΑ
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V T <sub>J</sub> =125℃			100	μΑ
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	2		4	V
<b>g</b> FS	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =40A		85		S
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =40A T <sub>J</sub> =25°C		4.3	5.4	mΩ
Dynamic Chara	cteristics			•		
Ciss	Input Capacitance			4930		pF
Coss	Output Capacitance	V <sub>DS</sub> =50V,V <sub>GS</sub> =0V, f=1.0MHz		1160		pF
Crss	Reverse Transfer Capacitance			42		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		1.4		Ω
Switching Para	meters					
t <sub>d(on)</sub>	Turn-on Delay Time			33		nS
t <sub>r</sub>	Turn-on Rise Time	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V,		18		nS
$t_{d(off)}$	Turn-Off Delay Time	R <sub>L</sub> =1.25Ω, R <sub>GEN</sub> =6Ω		70		nS
t <sub>f</sub>	Turn-Off Fall Time			108		nS
Qg	Total Gate Charge			71		nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =40A		20		nC
$Q_{gd}$	Gate-Drain Charge			14		nC
Source-Drain D	iode Characteristics	,		•		•
I <sub>SD</sub>	Source-Drain Current (Body Diode)				143	А
V <sub>SD</sub>	Forward on Voltage (Note 3)	V <sub>GS</sub> =0V, I <sub>S</sub> =40A			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> =40A, dI/dt=100A/μs		52		ns
Q <sub>rr</sub>	Reverse Recovery Charge	Ir=40A, dI/dt=100A/μs		84		nC

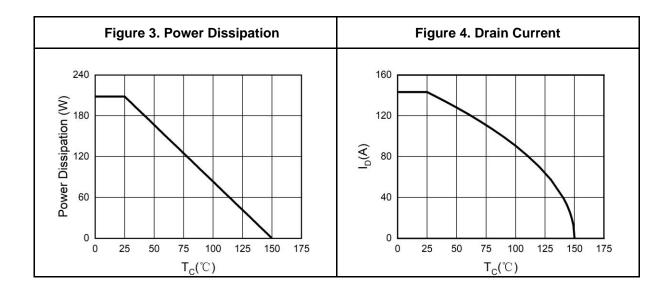
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

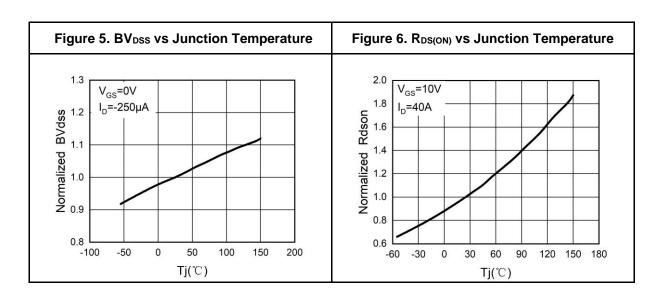
Notes 2.Eas condition: T\_J=25  $^{\circ}\text{C}$  ,V\_DD=50V,V\_G=10V, Rg=25 $\Omega$ , L=0.5mH.

Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

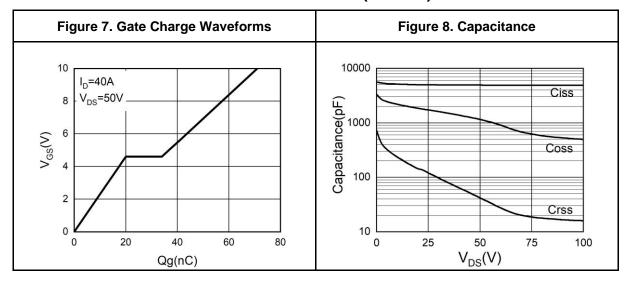
### **Typical Electrical And Thermal Characteristics (Curves)**

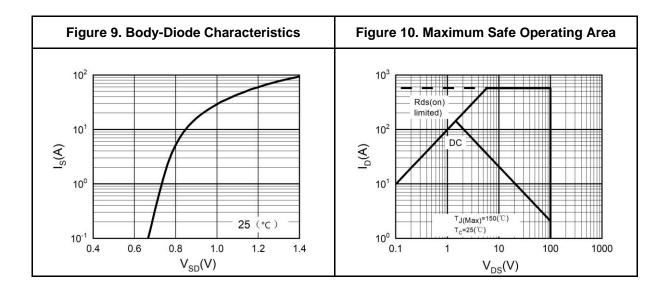






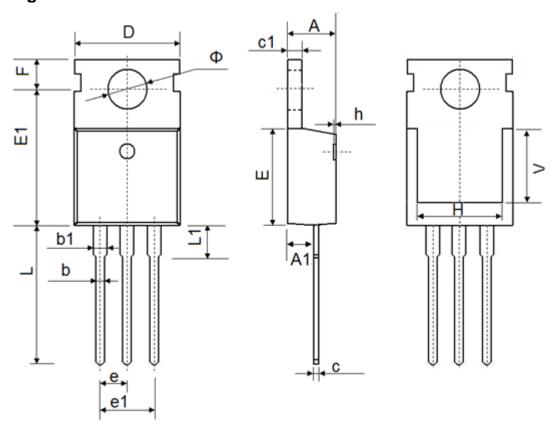
### **Typical Electrical And Thermal Characteristics (Curves)**







# **TO-220 Package Information**



Cumbal	Dimen	sions In Millimeters	Dim	ensions In Inches
Symbol	Min.	Max.	Min.	Max
Α	4.300	4.700	0.169	0.185
A1	2.200	2.600	0.087	0.102
b	0.700	0.950	0.028	0.037
b1	1.170	1.410	0.046	0.056
С	0.450	0.650	0.018	0.026
c1	1.200	1.400	0.047	0.055
D	9.600	10.400	0.378	0.409
E	8.8500	9.750	0.348	0.384
E1	12.650	12.950	0.498	0.510
е	2.540	TYP.	0.100T\	′P.
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
Н	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.750	14.300	0.502	0.563
L1	2.850	3.950	0.112	0.156
V	7.500	REF.	0.295 R	EF.
Ф	3.400	4.000	0.134	0.157



#### Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor

The performances and characteristics of this product in the independent testing state are displayed in this document. Wuxi Shangjia Semiconductor can't guarantee of the performances and characteristics of this described product that mounted in the customer's products or equipments as same as that in the independent testing state. So the customer should evaluate and test devices mounted in the customer's products or equipments.

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